

<b>Notice of References Cited</b>	Application/Control No. 10/541,137		Applicant(s)/Patent Under Reexamination SVENBRANDT ET AL.	
	Examiner Toan C. To		Art Unit 3616	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,311,325	12-2007	Tracht et al.	280/730.2
*	B	US-7,232,150	06-2007	Nagayama, Masaki	280/730.2
*	C	US-7,134,686	11-2006	Tracht et al.	280/730.2
*	D	US-7,004,496	02-2006	Bossecker et al.	280/730.2
*	E	US-6,578,911	06-2003	Harada et al.	297/216.13
*	F	US-6,450,528	09-2002	Suezawa et al.	280/730.2
*	G	US-6,352,304	03-2002	Sorgenfrei, Allen R.	297/216.13
*	H	US-6,341,797	01-2002	Seo, Kasumi	280/730.2
*	I	US-6,206,466	03-2001	Komatsu, Tadayoshi	297/216.13
*	J	US-6,155,593	12-2000	Kimura et al.	280/728.2
*	K	US-5,944,341	08-1999	Kimura et al.	280/728.3
*	L	US-5,957,486	09-1999	Taguchi et al.	280/729
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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